SBVS152C - DECEMBER 2010 - REVISED OCTOBER 2011



# 16-Channel, Constant-Current LED Driver with 4-Channel Grouped Delay

Check for Samples: TLC59282

### **FEATURES**

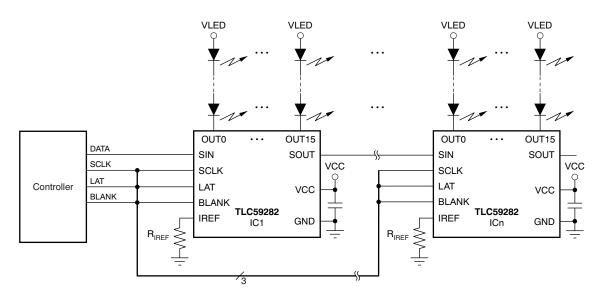
- 16 Channels, Constant-Current Sink Output with On/Off Control
- Capability (Constant-Current Sink): 35 mA (V<sub>CC</sub> ≤ 3.6 V), 45 mA (V<sub>CC</sub> > 3.6 V)
- LED Power-Supply Voltage up to 17 V
- V<sub>CC</sub> = 3 V to 5.5 V
- Constant-Current Accuracy:
  - Channel-to-Channel = ±0.6% (typ),±2% (max)
  - Device-to-Device =  $\pm 1\%$  (typ),  $\pm 3\%$  (max)
- Low Saturation Voltage: 0.31 V at 20 mA (typ)
  - $T_A = +25$ °C, One Channel On
- CMOS Logic Level I/O
- Data Transfer Rate: 35 MHz
- BLANK Pulse Width: 30 ns
- Four-Channel Grouped Delay for Noise Reduction
- Operating Temperature: –40°C to +85°C

## **APPLICATIONS**

- Video Displays
- Message Boards
- Illumination

# **DESCRIPTION**

The TLC59282 is a 16-channel, constant-current sink driver. Each channel can be individually controlled via a simple serial communications protocol that is compatible with 3.3 V or 5 V CMOS logic levels, depending on the operating VCC. Once the serial data buffer is loaded, a rising edge on LATCH transfers the data to the LEDx outputs. The BLANK pin can be used to turn off all OUTn outputs during power-on and output data latching to prevent unwanted image displays during these times. The constant-current value of all 16 channels is set by a single external resistor. Multiple TLC59282s can be cascaded together to control additional LEDs from the same processor.



Typical Application Circuit (Multiple Daisy-Chained TLC59282s)

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

# PACKAGE/ORDERING INFORMATION(1)

PRODUCT	PACKAGE-LEAD	ORDERING NUMBER	TRANSPORT MEDIA, QUANTITY
TI (CE0202	SSOP-24/QSOP-24	TLC59282DBQR	Tape and Reel, 2500
TLC59282	350P-24/Q50P-24	TLC59282DBQ	Tube, 50
TI (CE0202	OEN 24	TLC59282RGER	Tape and Reel, 3000
TLC59282	QFN-24	TLC59282RGE	Tape and Reel, 250

<sup>(1)</sup> For the most current package and ordering information, see the Package Option Addendum at the end of this document, or visit the device product folder at www.ti.com.

# **ABSOLUTE MAXIMUM RATINGS**(1)(2)

Over operating free-air temperature range, unless otherwise noted.

	PAR	AMETER	TLC59282	UNIT
$V_{CC}$	Supply voltage		-0.3 to +6	V
l <sub>OUT</sub>	Output current (dc)	OUT0 to OUT15	50	mA
$V_{IN}$	Input voltage range	SIN, SCLK, LAT, BLANK, IREF	-0.3 to V <sub>CC</sub> + 0.3	V
	Output voltage renge	SOUT	-0.3 to V <sub>CC</sub> + 0.3	V
V <sub>OUT</sub>	Output voltage range	OUT0 to OUT15	-0.3 to +18	V
$T_{J(MAX)}$	Operating junction temperature	re	+150	°C
T <sub>STG</sub>	Storage temperature range		–55 to +150	°C
	ECD roting	Human body model (HBM)	4000	V
	ESD rating	Charged device model (CDM)	1000	V

<sup>(1)</sup> Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not supported.

## THERMAL INFORMATION

		TLC		
	THERMAL METRIC <sup>(1)</sup>	DBQ	RGE	UNITS
		24 PINS	24 PINS	
$\theta_{JA}$	Junction-to-ambient thermal resistance	73.2	46.8	
$\theta_{JCtop}$	Junction-to-case (top) thermal resistance	44.6	48.6	
$\theta_{JB}$	Junction-to-board thermal resistance	38.9	23.0	°C///
ΨЈТ	Junction-to-top characterization parameter	12.3	1.2	°C/W
ΨЈВ	Junction-to-board characterization parameter	39.7	22.9	
$\theta_{JCbot}$	Junction-to-case (bottom) thermal resistance	n/a	6.3	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

<sup>(2)</sup> All voltage values are with respect to network ground terminal.

# **RECOMMENDED OPERATING CONDITIONS**

At  $T_A = -40^{\circ}$ C to +85°C, unless otherwise noted.

			Т	LC59282			
	PARAMETER	<b>TEST CONDITIONS</b>	MIN	NOM MAX		UNIT	
DC Charact	eristics: V <sub>CC</sub> = 3 V to 5.5 V						
V <sub>CC</sub>	Supply voltage		3		5.5	V	
Vo	Voltage applied to output	OUT0 to OUT15			17	V	
V <sub>IH</sub>	High-level input voltage		0.7 × V <sub>CC</sub>		V <sub>CC</sub>	V	
V <sub>IL</sub>	Low-level input voltage		GND		0.3 × V <sub>CC</sub>	V	
I <sub>ОН</sub>	High-level output current	SOUT			-1	mA	
I <sub>OL</sub>	Low-level output current	SOUT			1	mA	
	Constant autout sinh aurent	OUT0 to OUT15, 3 V ≤ V <sub>CC</sub> < 3.6 V	2		35	mA	
I <sub>OLC</sub> Co	Constant output sink current	OUT0 to OUT15, 3.6 V ≤ V <sub>CC</sub> < 5.5 V	2		45	mA	
T <sub>A</sub>	Operating free-air temperature range		-40		+85	°C	
T <sub>J</sub>	Operating junction temperature range		-40		+125	°C	
AC Charact	eristics: V <sub>CC</sub> = 3 V to 5.5 V						
f <sub>CLK (SCLK)</sub>	Data shift clock frequency	SCLK			35	MHz	
T <sub>WH0</sub>		SCLK	10			ns	
T <sub>WL0</sub>		SCLK	10			ns	
T <sub>WH1</sub>	Pulse duration	LAT	20			ns	
T <sub>WH2</sub>		BLANK	60			ns	
T <sub>WL2</sub>		BLANK	30			ns	
T <sub>SU0</sub>	Cotum time	SIN-SCLK↑	4			ns	
T <sub>SU1</sub>	Setup time	LAT↓-SCLK↑	10			ns	
T <sub>H0</sub>	Hold time	SIN-SCLK↑	4			ns	
T <sub>H1</sub>	Hold tille	LAT↓-SCLK↑	10			ns	



# **ELECTRICAL CHARACTERISTICS**

At  $V_{CC} = 3$  V to 5.5 V and  $T_A = -40$ °C to +85°C. Typical values at  $V_{CC} = 3.3$  V and  $T_A = +25$ °C, unless otherwise noted.

			Т	LC59282		
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	I <sub>OH</sub> = -1 mA at SOUT	V <sub>CC</sub> - 0.4		V <sub>cc</sub>	V
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 1 mA at SOUT			0.4	V
I <sub>IN</sub>	Input current	V <sub>IN</sub> = V <sub>CC</sub> or GND at SIN and SCLK	-1		1	μA
l <sub>cco</sub>		SIN/SCLK/LAT = low, BLANK = high, $V_{OUTn} = 1 \text{ V}$ , $R_{IREF} = \text{open}$		0.1	1	mA
CC1	Complete suggest (1/1)	SIN/SCLK/LAT = low, BLANK = high, $V_{OUTn}$ = 1 V, $R_{IREF}$ = 3 k $\Omega$ ( $I_{OUT}$ = 16.8 mA target)		4.5	6	mA
CC2	Supply current (V <sub>CC</sub> )	All OUTn = ON, SIN/SCLK/LAT/BLANK = low, $V_{OUTn}$ = 1 V, $R_{IREF}$ = 3 k $\Omega$	7		15	mA
ссз		All OUTn = ON, SIN/SCLK/LAT/BLANK = low, $V_{OUTn}$ = 1 V, $R_{IREF}$ = 1.5 k $\Omega$ ( $I_{OUT}$ = 33.6mA target)		16	34	mA
Госс	Constant output current	All OUTn = ON, $V_{OUTn}$ = $V_{OUTfix}$ = 1 V, $R_{IREF}$ = 1.5 k $\Omega$ at OUT0 to OUT15 (see Figure 6), $T_A$ = +25°C	32.1	33.7	35.3	mA
OLKG	Output leakage current	OUTn = OFF, $V_{OUTn} = V_{OUTfix} = 17 \text{ V}$ , BLANK = high, $R_{IREF} = 1.5 \text{ k}\Omega$ at OUT0 to OUT15 (see Figure 6)			0.1	μA
ΔI <sub>OLC0</sub>	Constant-current error (channel-to-channel) (1)	All OUTn = ON, $V_{OUTn}$ = $V_{OUTfix}$ = 1 V, $R_{IREF}$ = 1.5 $k\Omega$ at OUT0 to OUT15		±0.6	±2	%
∆I <sub>OLC1</sub>	Constant-current error (device-to-device) <sup>(2)</sup>	All OUTn = ON, $V_{OUTn}$ = $V_{OUTfix}$ = 1 V, $R_{IREF}$ = 1.5 k $\Omega$ at OUT0 to OUT15, $T_A$ = +25°C		±1	±3	%
ΔI <sub>OLC2</sub>	Line regulation <sup>(3)</sup>	All OUTn = ON, $V_{OUTn}$ = $V_{OUTfix}$ = 1 V, $R_{IREF}$ = 1.5 k $\Omega$ at OUT0 to OUT15, $V_{CC}$ = 3 V to 5.5 V		±0.5	±1	%/V
∆I <sub>OLC3</sub>	Load regulation <sup>(4)</sup>	All OUTn = ON, $V_{OUTn}$ = 1 V to 3V, $V_{OUTfix}$ = 1 V, $R_{IREF}$ = 1.5 k $\Omega$		±1	±3	%/V
V <sub>IREF</sub>	Reference voltage output	$R_{IREF} = 1.5 \text{ k}\Omega, T_A = +25^{\circ}\text{C}$	1.18	1.205	1.23	٧
R <sub>PUP</sub>	Pull-up resistor	BLANK	250	500	750	kΩ
R <sub>PDWN</sub>	Pull-down resistor	LAT	250	500	750	kΩ

(1) The deviation of each output from the average of OUT0-OUT15 constant-current. Deviation is calculated by the formula:

$$\Delta \text{ (\%)} = \left[ \frac{I_{\text{OUTn}}}{\frac{(I_{\text{OUT0}} + I_{\text{OUT1}} + \dots + I_{\text{OUT14}} + I_{\text{OUT15}})}{16}} - 1 \right] \times 100$$

The deviation of the OUT0-OUT15 constant-current average from the ideal constant-current value. Deviation is calculated by the following formula:

$$\Delta \text{ (\%)} = \left( \frac{\frac{(I_{\text{OUT0}} + I_{\text{OUT1}} + \dots I_{\text{OUT14}} + I_{\text{OUT15}})}{16} - \text{(Ideal Output Current)}}{\text{Ideal Output Current}} \right) \times 100$$

Ideal current is calculated by the formula: 
$$I_{OUT(IDEAL)} = 41.9 \times \left[ \frac{1.205}{R_{IREF}} \right]$$

(3) Line regulation is calculated by this equation: 
$$\Delta \ (\%/V) = \left\{ \frac{(I_{OUTn} \ at \ V_{CC} = 5.5 \ V) - (I_{OUTn} \ at \ V_{CC} = 3 \ V)}{(I_{OUTn} \ at \ V_{CC} = 3 \ V)} \right\} \times \frac{100}{5.5 \ V - 3 \ V}$$

(4) Load regulation is calculated by the equation:
$$\Delta \ (\%/V) = \left( \frac{(I_{OUTn} \text{ at } V_{OUTn} = 3 \text{ V}) - (I_{OUTn} \text{ at } V_{OUTn} = 1 \text{ V})}{(I_{OUTn} \text{ at } V_{OUTn} = 1 \text{ V})} \right) \times \frac{100}{3 \text{ V} - 1 \text{ V}}$$

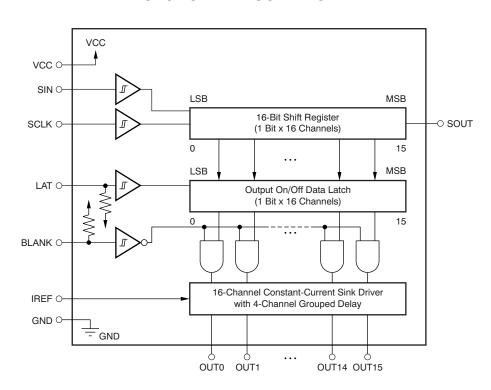
# **SWITCHING CHARACTERISTICS**

At  $V_{CC}$  = 3 V to 5.5 V,  $T_A$  = -40°C to +85°C,  $C_L$  = 15 pF,  $R_L$  = 130  $\Omega$ ,  $R_{IREF}$  = 1.5 k $\Omega$ , and  $V_{LED}$  = 5.5 V. Typical values at  $V_{CC}$  = 3.3 V and  $T_A$  = +25°C, unless otherwise noted.

			TI			
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>R0</sub>	Dies time	SOUT (see Figure 5)		5	12	ns
t <sub>R1</sub>	Rise time	OUTn (see Figure 4)		10	30	ns
t <sub>F0</sub>	Fall time	SOUT (see Figure 5)		5	12	ns
t <sub>F1</sub>	Fall time	OUTn (see Figure 4)		10	30	ns
t <sub>D0</sub>		SCLK↑ to SOUT↑↓		8	20	ns
t <sub>D1</sub>		LAT↑ or BLANK↑↓ to OUT0/OUT7/OUT8/OUT15 on/off		18	36	ns
t <sub>D2</sub>	Propagation delay time	LAT↑ or BLANK↑↓ to OUT1/OUT6/OUT9/OUT14 on/off		38	69	ns
t <sub>D3</sub>		LAT↑ or BLANK↑↓ to OUT2/OUT5/OUT10/OUT13 on/off		58	102	ns
t <sub>D4</sub>		LAT↑ or BLANK↑↓ to OUT3/OUT4/OUT11/OUT12 on/off		78	135	ns
t <sub>ON_ERR</sub>	Output on-time error <sup>(1)</sup>	On/off latch data = all '1', 30 ns BLANK low level one-shot pulse input	-15		15	ns

<sup>(1)</sup> Output on-time error  $(t_{ON\_ERR})$  is calculated by the formula:  $t_{ON\_ERR}$  (ns) =  $t_{OUT\_ON}$  – BLANK low level one-shot pulse width  $(T_{WL2})$ .  $t_{OUT\_ON}$  indicates the actual on-time of the constant-current output.

# **FUNCTIONAL BLOCK DIAGRAM**





(18

16

15

14

(13

**BLANK** 

OUT15

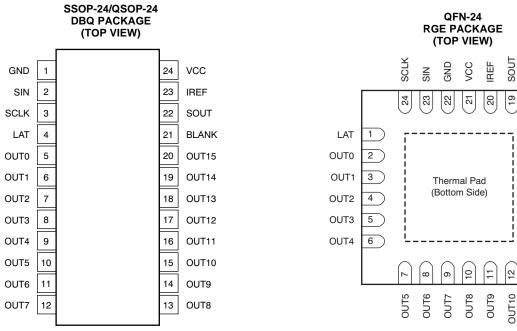
OUT14

OUT13

OUT12

OUT11

# **DEVICE INFORMATION**



NOTE: Thermal pad is not connected to GND internally. The thermal pad must be connected to GND via the PCB pattern.

# **TERMINAL FUNCTIONS**

NAME SIN SCLK LAT	2 3 4	23 24 1	I/O I I	DESCRIPTION  Serial data input for driver on/off control; Schmitt buffer input. When SIN is high, data '1' are written into the LSB of the 16-bit shift register at the SCLK rising edge.  Serial data shift clock; Schmitt buffer input. All data in the 16-bit shift register are shifted toward the MSB by 1-bit synchronization of SCLK.  Level triggered latch; Schmitt buffer input. The data in the 16-bit shift register continue to transfer
SCLK	3	24	I	written into the LSB of the 16-bit shift register at the SCLK rising edge.  Serial data shift clock; Schmitt buffer input. All data in the 16-bit shift register are shifted toward the MSB by 1-bit synchronization of SCLK.  Level triggered latch; Schmitt buffer input. The data in the 16-bit shift register continue to transfer
				the MSB by 1-bit synchronization of SCLK.  Level triggered latch; Schmitt buffer input. The data in the 16-bit shift register continue to transfer
LAT	4	1	1	
				to the output on/off data latch while LAT is high. Therefore, if the data in the 16-bit shift register are changed when LAT is high, the data in the data latch are also changed. The data in the data latch are held when LAT is low. This pin is internally pulled down to GND with a 500 k $\Omega$ (typ) resistor.
BLANK	21	18	1	Blank, all outputs; Schmitt buffer input. When BLANK is high, all constant-current outputs (OUT0–OUT15) are forced off. When BLANK is low, all constant-current outputs are controlled by the data in the output on/off data latch. This pin is internally pulled up to $V_{CC}$ with a 500 k $\Omega$ (typ) resistor.
IREF	23	20	I/O	Constant-current value setting, OUT0–OUT15 sink constant-current is set to desired value by connection to an external resistor between IREF and GND.
SOUT	22	19	0	Serial data output. This output is connected to the MSB of the 16-bit shift register. SOUT data changes at the rising edge of SCLK.
ОПТО	5	2	0	Constant-current output. Each output can be tied together with others to increase the constant-current. Different voltages can be applied to each output.
OUT1	6	3	0	Constant-current output
OUT2	7	4	0	Constant-current output
OUT3	8	5	0	Constant-current output
OUT4	9	6	0	Constant-current output
OUT5	10	7	0	Constant-current output
OUT6	11	8	0	Constant-current output
OUT7	12	9	0	Constant-current output
OUT8	13	10	0	Constant-current output
OUT9	14	11	0	Constant-current output
OUT10	15	12	0	Constant-current output
OUT11	16	13	0	Constant-current output
OUT12	17	14	0	Constant-current output
OUT13	18	15	0	Constant-current output
OUT14	19	16	0	Constant-current output
OUT15	20	17	0	Constant-current output
VCC	24	21	_	Power-supply voltage
GND	1	22	_	Power ground



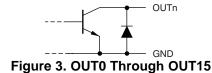
#### PARAMETER MEASUREMENT INFORMATION

# PIN EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS

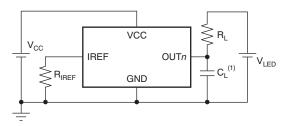


Figure 1. SIN, SCLK, LAT, BLANK

Figure 2. SOUT

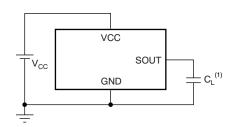


# **TEST CIRCUITS**



(1) C<sub>1</sub> includes measurement probe and jig capacitance.

Figure 4. Rise Time and Fall Time Test Circuit for



(1)  $C_L$  includes measurement probe and jig capacitance.

Figure 5. Rise Time and Fall Time Test Circuit for SOUT

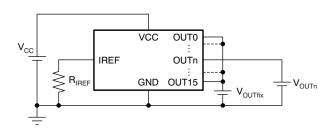
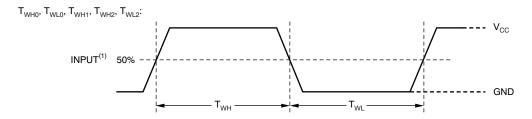
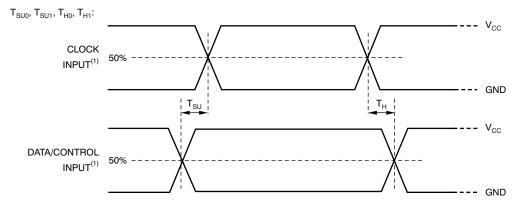


Figure 6. Constant-Current Test Circuit for OUTn



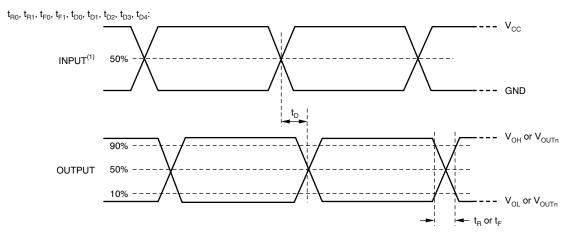
# **TIMING DIAGRAMS**





(1) Input pulse rise and fall time is 1 ns to 3 ns.

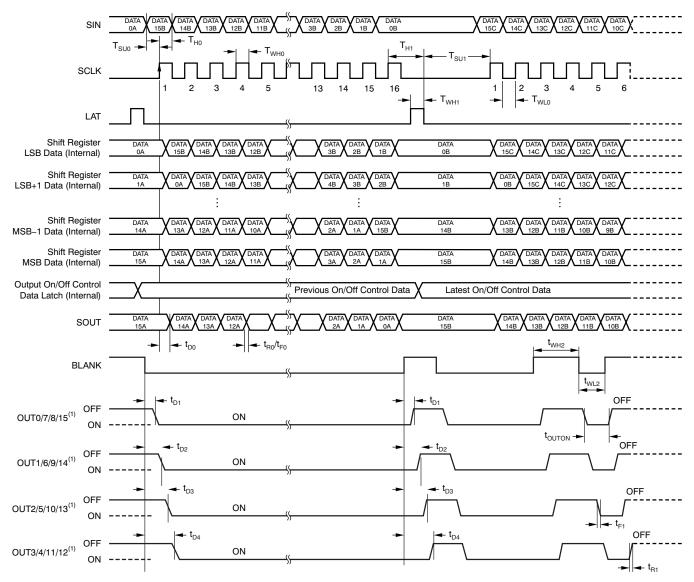
Figure 7. Input Timing



(1) Input pulse rise and fall time is 1 ns to 3 ns.

Figure 8. Output Timing





- (1) Output on/off data = FFFFh.
- (2)  $t_{ON\_ERR} = t_{OUTON} T_{WL2}$ .

Figure 9. Timing Diagram



#### TYPICAL CHARACTERISTICS

At  $V_{CC}$  = 3.3 V and  $T_A$  = +25°C, unless otherwise noted.

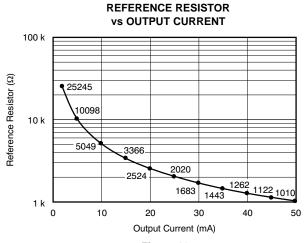


Figure 10.

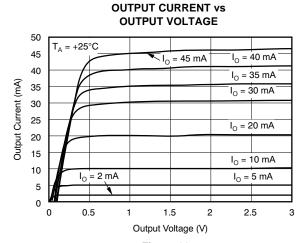


Figure 11.

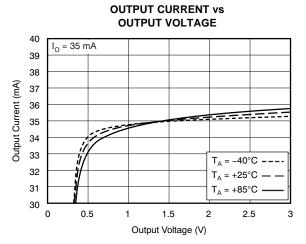


Figure 12.

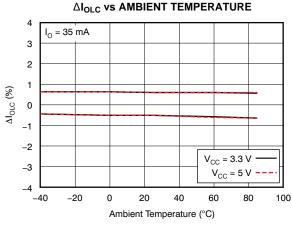


Figure 13.

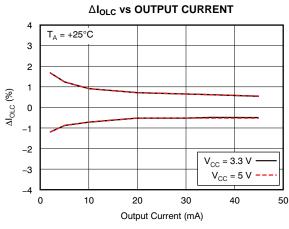


Figure 14.

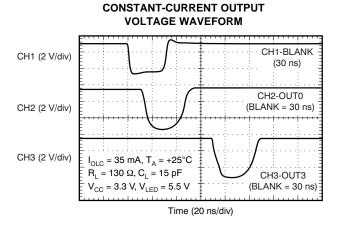


Figure 15.



#### DETAILED DESCRIPTION

#### SETTING FOR THE CONSTANT SINK CURRENT VALUE

The constant-current values are determined by an external resistor ( $R_{IREF}$ ) placed between IREF and GND. The resistor ( $R_{IREF}$ ) value is calculated by Equation 1.

$$R_{IREF} (k\Omega) = \frac{V_{IREF} (V)}{I_{OLC} (mA)} \times 41.9$$

Where:

$$V_{IREF}$$
 = the internal reference voltage on the IREF pin (typically 1.205 V) (1)

 $I_{OLC}$  must be set in the range of 2 mA to 35 mA when  $V_{CC}$  is less than 3.6 V. Also, when  $V_{CC}$  is equal to 3.6 V or greater,  $I_{OLC}$  must be set in the range of 2 mA to 45 mA. The constant sink current characteristic for the external resistor value is shown in Figure 10. Table 1 describes the constant-current output versus external resistor value.

Table 1. Constant-Current Output versus External Resistor Value

I <sub>OLC</sub> (mA, Typical)	R <sub>IREF</sub> (kΩ)
45 (V <sub>CC</sub> > 3.6 V only)	1.12
40 (V <sub>CC</sub> > 3.6 V only)	1.26
35	1.44
30	1.68
25	2.02
20	2.52
15	3.37
10	5.05
5	10.1
2	25.2

#### CONSTANT-CURRENT DRIVER ON/OFF CONTROL

When BLANK is low, the corresponding output is turned on if the data in the on/off control data latch are '1' and remains off if the data are '0'. When BLANK is high, all outputs are forced off. This control is shown in Table 2.

Table 2. On/Off Control Data Truth Table

OUTPUT ON/OFF DATA	CONSTANT-CURRENT OUTPUT STATUS
0	Off
1	On

When the IC is initially powered on, the data in the 16-bit shift register and output on/off data latch are not set to the respective default value. Therefore, the output on/off data must be written to the data latch before turning the constant-current output on. BLANK should be at a high level when powered on because the constant-current may be turned on as a result of random data in the output on/off data latch.

The output on/off data corresponding to any unconnected OUTn outputs should be set to '0' before turning on the remaining outputs. Otherwise, the supply current (I<sub>CC</sub>) increases while the LEDs are on.

#### **REGISTER CONFIGURATION**

The TLC59282 has a 16-bit shift register and an output on/off data latch. Both the shift register and data latch are 16 bits long and are used to turn the constant-current outputs on and off. Figure 16 shows the shift register and data latch configuration. The data at the SIN pin are shifted in to the LSB of the 16-bit shift register at the rising edge of the SCLK pin; SOUT data change at the rising edge of SCLK.

The output on/off data in the 16-bit shift register continue to transfer to the output on/off data latch while LAT is high. Therefore, if the data in the 16-bit shift register are changed when LAT is high, the data in the data latch are also changed. The data in the data latch are held when LAT is low. When the IC initially powers on, the data in the output on/off shift register and latch are not set to the default values; on/off control data must be written to the on/off control data latch before turning the constant-current output on. BLANK should be high when the IC is powered on because the constant-current may be turned on at that time as a result of random values in the on/off data latch. All constant-current outputs are forced off when BLANK is high. The OUTn on/off are controlled by the data in the output on/off data latch. The timing diagram and truth table for writing data are shown in Figure 17 and Table 3.

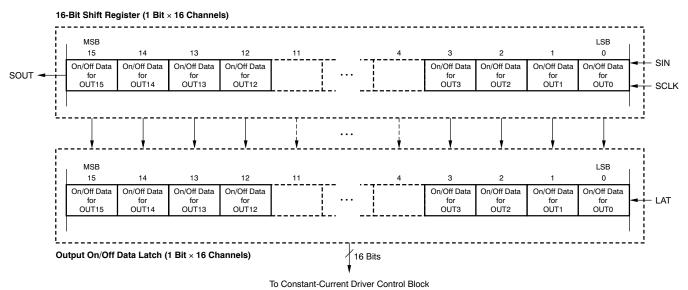


Figure 16. 16-Bit Shift Register and Output On/Off Data Latch Configuration



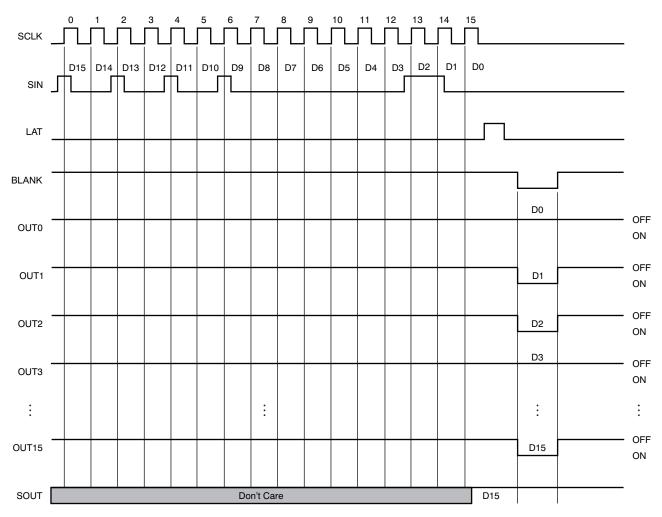


Figure 17. Operation Timing Diagram

**SCLK** LAT **BLANK** SIN OUT0...OUT7...OUT15 SOUT High Dn Dn...Dn - 7...Dn - 15 Dn - 15 Low 1 Low Low Dn + 1 No change Dn - 14 1 Dn + 2 Dn + 2...Dn - 5...Dn - 13 Dn - 13 High Low 1 Dn + 3 Dn + 2...Dn - 5...Dn - 13 Dn - 13 Low Dn + 3Dn - 13 High Off

**Table 3. Truth Table in Operation** 

# **NOISE REDUCTION**

Large surge currents may flow through the IC and the board if all 16 outputs turn on or off simultaneously. These large current surges could induce detrimental noise and electromagnetic interference (EMI) into other circuits. The TLC59282 independently turns on or off the outputs for each color group with a 20 ns (typ) delay time; see Figure 9. The output current sinks are grouped into four groups. The first group that is turned on/off are OUT0/7/8/15; the second group that is turned on/off are OUT1/6/9/14; the third group that is turned on/off are OUT2/5/10/13; and the fourth group is OUT3/4/11/12. Both turn-on and turn-off are delayed. However, the state of each output is controlled by the data in the output on-off data latch and BLANK level.

# **REVISION HISTORY**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision B (July 2011) to Revision C	Page
Added Low Saturation Voltage Features bullet	1
Changes from Revision A (December 2010) to Revision B	Page
Changed Constant-Current Accuracy Features bullet	1
Added RGE package information to Package/Ordering Information table	2
Added RGE package to Thermal Information table	2
• Changed Input current parameter test conditions in Electrical Characteristic	s table4
Added RGE pin out and footnote to Device Information section	6
Added RGE information to Terminal Functions table	
• Deleted Figure 11, POWER DISSIPATION RATE vs FREE-AIR TEMPERA	TURE 11

# PACKAGE OPTION ADDENDUM



10-Dec-2020

#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TLC59282DBQ	ACTIVE	SSOP	DBQ	24	50	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TLC59282	Samples
TLC59282DBQR	ACTIVE	SSOP	DBQ	24	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TLC59282	Samples
TLC59282RGER	ACTIVE	VQFN	RGE	24	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TLC 59282	Samples
TLC59282RGET	ACTIVE	VQFN	RGE	24	250	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TLC 59282	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# PACKAGE OPTION ADDENDUM



10-Dec-2020

continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

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# TAPE AND REEL INFORMATION





A0	
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

All differsions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC59282DBQR	SSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC59282RGER	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
TLC59282RGET	VQFN	RGE	24	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

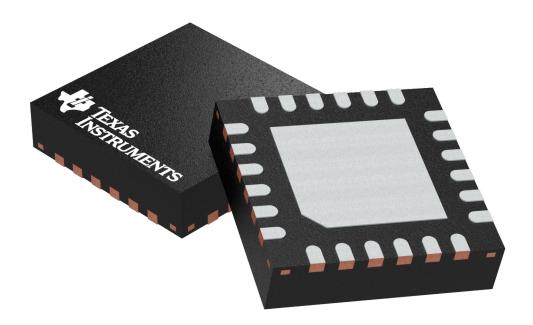
www.ti.com 30-Dec-2020



\*All dimensions are nominal

7 till dillittorioriorio di o mominidi								
Device	Package Type	Package Drawing	Pins SPQ		Length (mm)	Width (mm)	Height (mm)	
TLC59282DBQR	SSOP	DBQ	24	2500	367.0	367.0	38.0	
TLC59282RGER	VQFN	RGE	24	3000	853.0	449.0	35.0	
TLC59282RGET	VQFN	RGE	24	250	210.0	185.0	35.0	

PLASTIC QUAD FLATPACK - NO LEAD

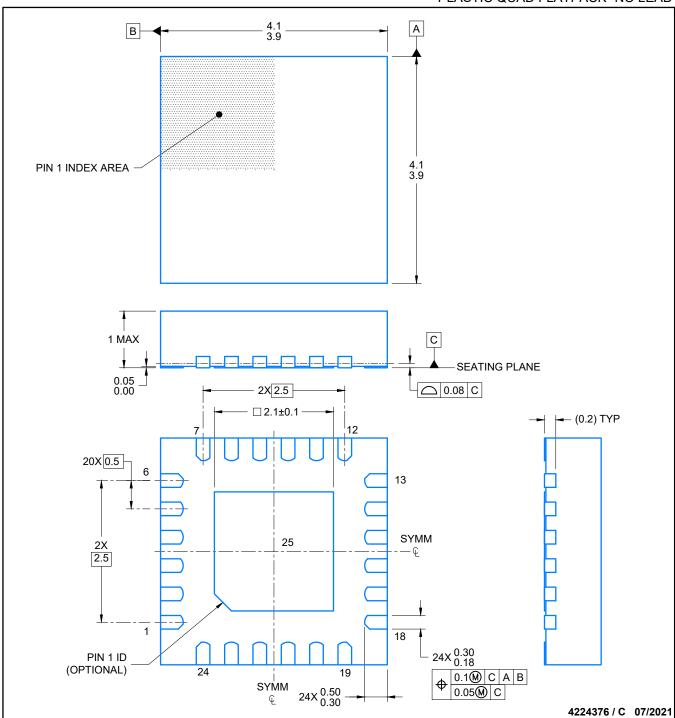


Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4204104/H



PLASTIC QUAD FLATPACK- NO LEAD

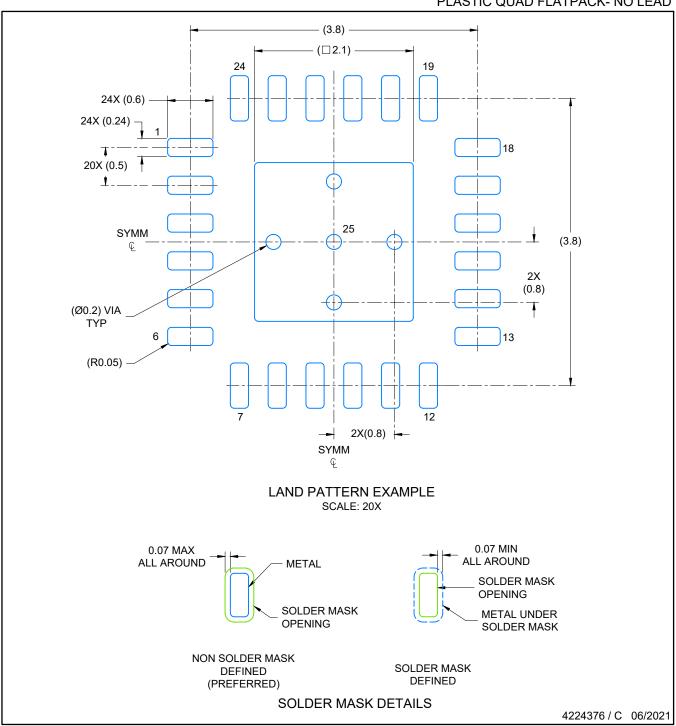


# NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC QUAD FLATPACK- NO LEAD

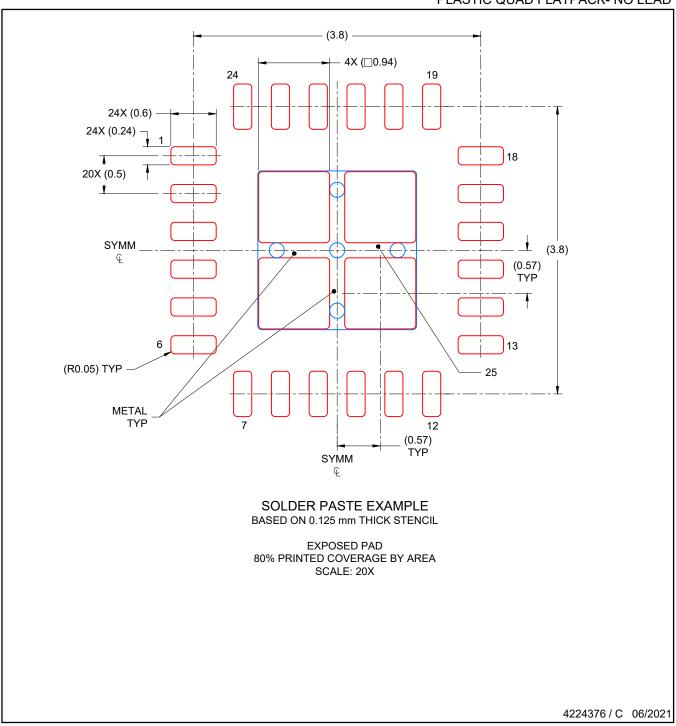


NOTES: (continued)

- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PLASTIC QUAD FLATPACK- NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..



DBQ (R-PDSO-G24)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
- D. Falls within JEDEC MO-137 variation AE.



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